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## Three-dimensional scanning near field optical microscopy imaging of random arrays of copper nanoparticles and their use for plasmonic solar cell enhancement

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In order to investigate the suitability of random arrays of nanoparticles for plasmonic enhancement in the visible-near infrared range, we introduced three-dimensional scanning near-field optical microscopy (3D-SNOM) imaging as a useful technique to probe the intensity of near-field radiation scattered by random systems of nanoparticles at heights up to several hundred nm from their surface [1]. We demonstrated our technique using random arrays of copper nanoparticles (Cu-NPs) at different particle diameter and concentration. Bright regions in the 3D-SNOM images, corresponding to constructive interference of forward-scattered plasmonic waves, were obtained at heights  $\Delta z \ge 220$  nm from the surface for random arrays of Cu-NPs of about 60–100 nm in diameter. These heights are too large to use Cu-NPs in contact of the active layer for light harvesting in thin organic solar cells, which are typically no thicker than 200 nm. Using a 200 nm transparent spacer between the system of Cu-NPs and the solar cell active layer, we demonstrate that forward-scattered light can be conveyed in 200 nm thin film solar cells. This architecture increases the solar cell photoconversion efficiency by a factor of 3. Our 3D-SNOM technique is general enough to be suitable for a large number of other applications in nanoplasmonics.

[1] S. Ezugwu, H. Ye and G. Fanchini, Nanoscale 7 (2015) 252-260.

Author: Mr EZUGWU, Sabastine (The University of Western Ontario)

**Co-authors:** Prof. FANCHINI, Giovanni (The University of Western Ontario); Mr YE, Hanyang (The University of Western Ontario)

Presenter: Mr EZUGWU, Sabastine (The University of Western Ontario)

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